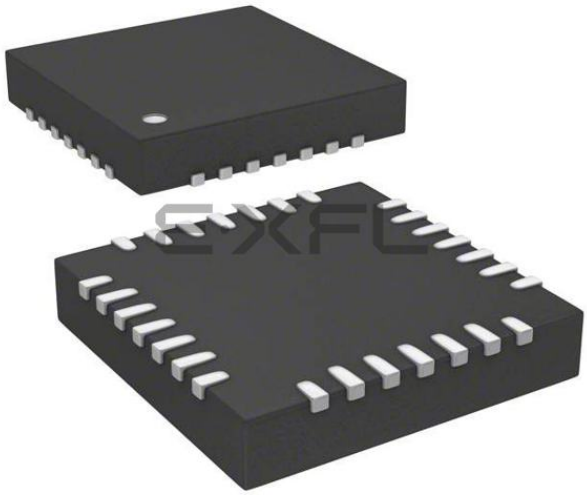

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Applications of "Embedded - Microcontrollers"

Details	
Product Status	Active
Core Processor	STM8
Core Size	8-Bit
Speed	16MHz
Connectivity	I²C, IrDA, SPI, UART/USART
Peripherals	Brown-out Detect/Reset, DMA, IR, POR, PWM, WDT
Number of I/O	26
Program Memory Size	16KB (16K x 8)
Program Memory Type	FLASH
EEPROM Size	1K x 8
RAM Size	2K x 8
Voltage - Supply (Vcc/Vdd)	1.8V ~ 3.6V
Data Converters	A/D 18x12b; D/A 1x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	28-UFQFN
Supplier Device Package	28-UFQFPN (4x4)
Purchase URL	https://www.e-xfl.com/product-detail/stmicroelectronics/stm8l151g4u6tr

2.1 Device overview

Table 2. Medium-density STM8L151x4/6 and STM8L152x4/6 low-power device features and peripheral counts

Features		STM8L151Gx		STM8L15xKx		STM8L15xCx	
Flash (Kbyte)		16	32	16	32	16	32
Data EEPROM (Kbyte)		1					
RAM (Kbyte)		2					
LCD		No		4x17 (1)		4x28 (1)	
Timers	Basic	1 (8-bit)					
	General purpose	2 (16-bit)					
	Advanced control	1 (16-bit)					
Communication interfaces	SPI	1					
	I2C	1					
	USART	1					
GPIOs		26(3)		30 (2)(3) or 29 (1)(3)		41(3)	
12-bit synchronized ADC (number of channels)		1 (18)		1 (22 (2) or 21 (1))		1 (25)	
12-Bit DAC (number of channels)		1 (1)					
Comparators COMP1/COMP2		2					
Others		RTC, window watchdog, independent watchdog, 16-MHz and 38-kHz internal RC, 1- to 16-MHz and 32-kHz external oscillator					
CPU frequency		16 MHz					
Operating voltage		1.8 V to 3.6 V (down to 1.65 V at power down)					
Operating temperature		-40 to +85 °C/ -40 to +105 °C / -40 to +125 °C					
Packages		UFQFPN28 (4x4; 0.6 mm thickness) WLCSP28		LQFP32(7x7) UFQFPN32 (5x5; 0.6 mm thickness)		LQFP48 UFQFPN48 (4x4; 0.6 mm thickness)	

1. STM8L152xx versions only
2. STM8L151xx versions only
3. The number of GPIOs given in this table includes the NRST/PA1 pin but the application can use the NRST/PA1 pin as general purpose output only (PA1).

IWDG: Independent watchdog
LCD: Liquid crystal display
POR/PDR: Power on reset / power down reset
RTC: Real-time clock
SPI: Serial peripheral interface
SWIM: Single wire interface module
USART: Universal synchronous asynchronous receiver transmitter
WWDG: Window watchdog

3.1 Low-power modes

The medium-density STM8L151x4/6 and STM8L152x4/6 devices support five low power modes to achieve the best compromise between low power consumption, short startup time and available wakeup sources:

- **Wait mode**: The CPU clock is stopped, but selected peripherals keep running. An internal or external interrupt, event or a Reset can be used to exit the microcontroller from Wait mode (WFE or WFI mode). Wait consumption: refer to *Table 21*.
- **Low power run mode**: The CPU and the selected peripherals are running. Execution is done from RAM with a low speed oscillator (LSI or LSE). Flash and data EEPROM are stopped and the voltage regulator is configured in ultra-low-power mode. The microcontroller enters Low power run mode by software and can exit from this mode by software or by a reset.
  All interrupts must be masked. They cannot be used to exit the microcontroller from this mode. Low power run mode consumption: refer to *Table 22*.
- **Low power wait mode:** This mode is entered when executing a Wait for event in Low power run mode. It is similar to Low power run mode except that the CPU clock is stopped. The wakeup from this mode is triggered by a Reset or by an internal or external event (peripheral event generated by the timers, serial interfaces, DMA controller (DMA1), comparators and I/O ports). When the wakeup is triggered by an event, the system goes back to Low power run mode.
  All interrupts must be masked. They cannot be used to exit the microcontroller from this mode. Low power wait mode consumption: refer to *Table 23*.
- **Active-halt mode**: CPU and peripheral clocks are stopped, except RTC. The wakeup can be triggered by RTC interrupts, external interrupts or reset. Active-halt consumption: refer to *Table 24* and *Table 25*.
- **Halt mode**: CPU and peripheral clocks are stopped, the device remains powered on. The RAM content is preserved. The wakeup is triggered by an external interrupt or reset. A few peripherals have also a wakeup from Halt capability. Switching off the internal reference voltage reduces power consumption. Through software configuration it is also possible to wake up the device without waiting for the internal reference voltage wakeup time to have a fast wakeup time of 5 µs. Halt consumption: refer to *Table 26*.

Table 5. Medium-density STM8L151x4/6, STM8L152x4/6 pin description (continued)

Pin number				Pin name	Type	I/O level	Input			Output			Main function (after reset)	Default alternate function
LQFP48/UFQFPN48	LQFP32/UFQFPN32	UFQFPN28	WLCSP28				floating	wpu	Ext. interrupt	High sink/source	OD	PP		
-	16	-	-	PB3/*[TIM2_ETR]*(4)/ TIM1_CH2N/LCD_SEG13(2)/ADC1_IN15/ COMP1_INP	I/O	TT(3)	**X**	X	X	HS	X	X	**Port B3**	*[Timer 2 - external trigger]* / Timer 1 inverted channel 2 / LCD segment 13 / ADC1_IN15 / Comparator 1 positive input
-	-	15	E2	PB3/*[TIM2_ETR]*(4)/ TIM1_CH1N/ LCD_SEG13(2)/ ADC1_IN15/RTC_ALARM /COMP1_INP	I/O	TT(3)	**X**	X	X	HS	X	X	**Port B3**	*[Timer 2 - external trigger]* / Timer 1 inverted channel 1/ LCD segment 13 / ADC1_IN15 / RTC alarm/ Comparator 1 positive input
28	-	-	-	PB4(6)/*[SPI1_NSS]*(4)/ LCD_SEG14(2)/ ADC1_IN14/COMP1_INP	I/O	TT(3)	**X**(6)	X(6)	X	HS	X	X	**Port B4**	*[SPI1 master/slave select]* / LCD segment 14 / ADC1_IN14 / Comparator 1 positive input
-	17	16	D2	PB4(6)/*[SPI1_NSS]*(4)/ LCD_SEG14(2)/ ADC1_IN14/ COMP1_INP/DAC_OUT	I/O	TT(3)	**X**(6)	X(6)	X	HS	X	X	**Port B4**	*[SPI1 master/slave select]* / LCD segment 14 / ADC1_IN14 / DAC output / Comparator 1 positive input
29	-	-	-	PB5/*[SPI1_SCK]*(4)/ LCD_SEG15(2)/ ADC1_IN13/COMP1_INP	I/O	TT(3)	**X**	X	X	HS	X	X	**Port B5**	*[SPI1 clock]* / LCD segment 15 / ADC1_IN13 / Comparator 1 positive input
-	18	17	D1	PB5/*[SPI1_SCK]*(4)/ LCD_SEG15(2)/ ADC1_IN13/DAC_OUT/ COMP1_INP	I/O	TT(3)	**X**	X	X	HS	X	X	**Port B5**	*[SPI1 clock]* / LCD segment 15 / ADC1_IN13 / DAC output/ Comparator 1 positive input

Table 9. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 5055 to 0x00 506F	Reserved area (27 bytes)			
0x00 5070	DMA1	DMA1_GCSR	DMA1 global configuration & status register	0xFC
0x00 5071		DMA1_GIR1	DMA1 global interrupt register 1	0x00
0x00 5072 to 0x00 5074		Reserved area (3 bytes)		
0x00 5075		DMA1_C0CR	DMA1 channel 0 configuration register	0x00
0x00 5076		DMA1_C0SPR	DMA1 channel 0 status & priority register	0x00
0x00 5077		DMA1_C0NDTR	DMA1 number of data to transfer register (channel 0)	0x00
0x00 5078		DMA1_C0PARH	DMA1 peripheral address high register (channel 0)	0x52
0x00 5079		DMA1_C0PARL	DMA1 peripheral address low register (channel 0)	0x00
0x00 507A		Reserved area (1 byte)		
0x00 507B		DMA1_C0M0ARH	DMA1 memory 0 address high register (channel 0)	0x00
0x00 507C		DMA1_C0M0ARL	DMA1 memory 0 address low register (channel 0)	0x00
0x00 507D to 0x00 507E		Reserved area (2 bytes)		
0x00 507F		DMA1_C1CR	DMA1 channel 1 configuration register	0x00
0x00 5080		DMA1_C1SPR	DMA1 channel 1 status & priority register	0x00
0x00 5081		DMA1_C1NDTR	DMA1 number of data to transfer register (channel 1)	0x00
0x00 5082		DMA1_C1PARH	DMA1 peripheral address high register (channel 1)	0x52
0x00 5083		DMA1_C1PARL	DMA1 peripheral address low register (channel 1)	0x00

Table 9. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 50D0 to 0x00 50D2	Reserved area (3 bytes)			
0x00 50D3	WWDG	WWDG_CR	WWDG control register	0x7F
0x00 50D4		WWDG_WR	WWDR window register	0x7F
0x00 50D5 to 00 50DF	Reserved area (11 bytes)			
0x00 50E0	IWDG	IWDG_KR	IWDG key register	0xXX
0x00 50E1		IWDG_PR	IWDG prescaler register	0x00
0x00 50E2		IWDG_RLR	IWDG reload register	0xFF
0x00 50E3 to 0x00 50EF	Reserved area (13 bytes)			
0x00 50F0	BEEP	BEEP_CSR1	BEEP control/status register 1	0x00
0x00 50F1 0x00 50F2		Reserved area (2 bytes)		
0x00 50F3		BEEP_CSR2	BEEP control/status register 2	0x1F
0x00 50F4 to 0x00 513F	Reserved area (76 bytes)			

Table 9. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 5200	SPI1	SPI1_CR1	SPI1 control register 1	0x00
0x00 5201		SPI1_CR2	SPI1 control register 2	0x00
0x00 5202		SPI1_ICR	SPI1 interrupt control register	0x00
0x00 5203		SPI1_SR	SPI1 status register	0x02
0x00 5204		SPI1_DR	SPI1 data register	0x00
0x00 5205		SPI1_CRCPR	SPI1 CRC polynomial register	0x07
0x00 5206		SPI1_RXCRCR	SPI1 Rx CRC register	0x00
0x00 5207		SPI1_TXCRCR	SPI1 Tx CRC register	0x00
0x00 5208 to 0x00 520F	Reserved area (8 bytes)			
0x00 5210	I2C1	I2C1_CR1	I2C1 control register 1	0x00
0x00 5211		I2C1_CR2	I2C1 control register 2	0x00
0x00 5212		I2C1_FREQR	I2C1 frequency register	0x00
0x00 5213		I2C1_OARL	I2C1 own address register low	0x00
0x00 5214		I2C1_OARH	I2C1 own address register high	0x00
0x00 5215		Reserved (1 byte)		
0x00 5216		I2C1_DR	I2C1 data register	0x00
0x00 5217		I2C1_SR1	I2C1 status register 1	0x00
0x00 5218		I2C1_SR2	I2C1 status register 2	0x00
0x00 5219		I2C1_SR3	I2C1 status register 3	0x0x
0x00 521A		I2C1_ITR	I2C1 interrupt control register	0x00
0x00 521B		I2C1_CCRL	I2C1 clock control register low	0x00
0x00 521C		I2C1_CCRH	I2C1 clock control register high	0x00
0x00 521D		I2C1_TRISER	I2C1 TRISE register	0x02
0x00 521E		I2C1_PECR	I2C1 packet error checking register	0x00
0x00 521F to 0x00 522F	Reserved area (17 bytes)			

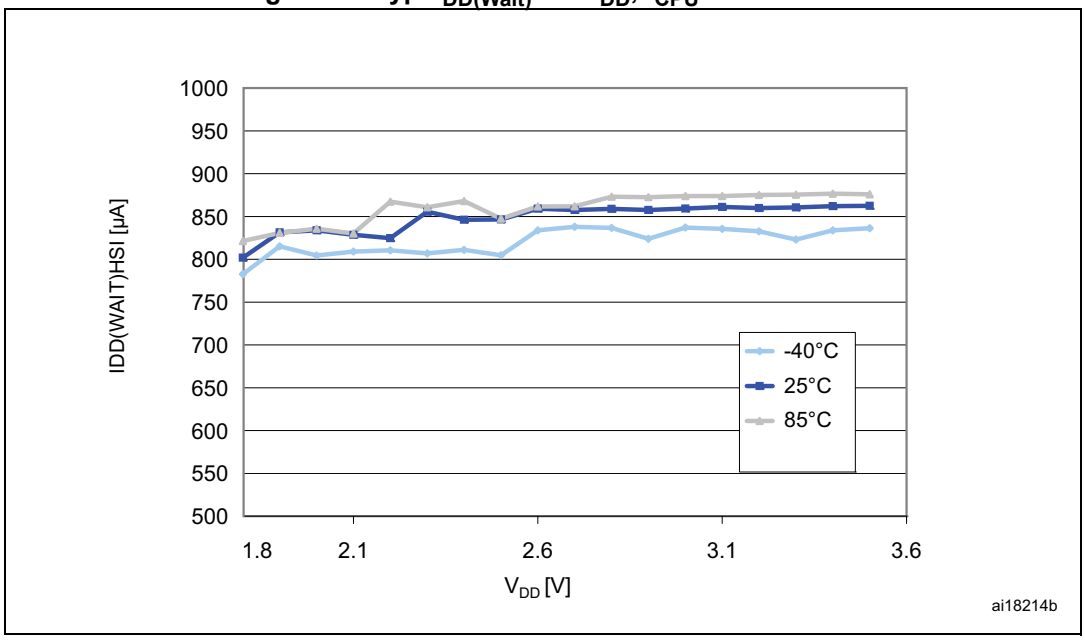
Table 9. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 52B0	TIM1	TIM1_CR1	TIM1 control register 1	0x00
0x00 52B1		TIM1_CR2	TIM1 control register 2	0x00
0x00 52B2		TIM1_SMCR	TIM1 Slave mode control register	0x00
0x00 52B3		TIM1_ETR	TIM1 external trigger register	0x00
0x00 52B4		TIM1_DER	TIM1 DMA1 request enable register	0x00
0x00 52B5		TIM1_IER	TIM1 Interrupt enable register	0x00
0x00 52B6		TIM1_SR1	TIM1 status register 1	0x00
0x00 52B7		TIM1_SR2	TIM1 status register 2	0x00
0x00 52B8		TIM1_EGR	TIM1 event generation register	0x00
0x00 52B9		TIM1_CCMR1	TIM1 Capture/Compare mode register 1	0x00
0x00 52BA		TIM1_CCMR2	TIM1 Capture/Compare mode register 2	0x00
0x00 52BB		TIM1_CCMR3	TIM1 Capture/Compare mode register 3	0x00
0x00 52BC		TIM1_CCMR4	TIM1 Capture/Compare mode register 4	0x00
0x00 52BD		TIM1_CCER1	TIM1 Capture/Compare enable register 1	0x00
0x00 52BE		TIM1_CCER2	TIM1 Capture/Compare enable register 2	0x00
0x00 52BF		TIM1_CNTRH	TIM1 counter high	0x00
0x00 52C0		TIM1_CNTRL	TIM1 counter low	0x00
0x00 52C1		TIM1_PSCRH	TIM1 prescaler register high	0x00
0x00 52C2		TIM1_PSCRL	TIM1 prescaler register low	0x00
0x00 52C3		TIM1_ARRH	TIM1 Auto-reload register high	0xFF
0x00 52C4		TIM1_ARRL	TIM1 Auto-reload register low	0xFF
0x00 52C5		TIM1_RCR	TIM1 Repetition counter register	0x00
0x00 52C6		TIM1_CCR1H	TIM1 Capture/Compare register 1 high	0x00
0x00 52C7		TIM1_CCR1L	TIM1 Capture/Compare register 1 low	0x00
0x00 52C8		TIM1_CCR2H	TIM1 Capture/Compare register 2 high	0x00
0x00 52C9		TIM1_CCR2L	TIM1 Capture/Compare register 2 low	0x00
0x00 52CA		TIM1_CCR3H	TIM1 Capture/Compare register 3 high	0x00
0x00 52CB		TIM1_CCR3L	TIM1 Capture/Compare register 3 low	0x00
0x00 52CC		TIM1_CCR4H	TIM1 Capture/Compare register 4 high	0x00
0x00 52CD		TIM1_CCR4L	TIM1 Capture/Compare register 4 low	0x00
0x00 52CE		TIM1_BKR	TIM1 break register	0x00
0x00 52CF		TIM1_DTR	TIM1 dead-time register	0x00
0x00 52D0		TIM1_OISR	TIM1 output idle state register	0x00
0x00 52D1		TIM1_DCR1	DMA1 control register 1	0x00

Table 13. Option byte description (continued)

Option byte No.	Option description
OPT5	**BOR_ON**: 0: Brownout reset off 1: Brownout reset on
	BOR_TH[3:1]: Brownout reset thresholds. Refer to *Table 23* for details on the thresholds according to the value of BOR_TH bits.
OPTBL	**OPTBL[15:0]**: This option is checked by the boot ROM code after reset. Depending on content of addresses 00 480B, 00 480C and 0x8000 (reset vector) the CPU jumps to the bootloader or to the reset vector. Refer to the UM0560 bootloader user manual for more details.

Figure 14. Typ. $I_{DD(Wait)}$ vs. V_{DD}, f_{CPU} = 16 MHz [1)]



1. Typical current consumption measured with code executed from Flash memory.

Table 38. I/O static characteristics

Symbol	Parameter	Conditions(1)	Min	Typ	Max	Unit
V_{IL}	Input low level voltage(2)	Input voltage on true open-drain pins (PC0 and PC1)	V_{SS}-0.3	-	0.3 x V_{DD}	V
		Input voltage on five-volt tolerant (FT) pins (PA7 and PE0)	V_{SS}-0.3	-	0.3 x V_{DD}	
		Input voltage on 3.6 V tolerant (TT) pins	V_{SS}-0.3	-	0.3 x V_{DD}	
		Input voltage on any other pin	V_{SS}-0.3	-	0.3 x V_{DD}	
V_{IH}	Input high level voltage (2)	Input voltage on true open-drain pins (PC0 and PC1) with V_{DD} < 2 V	0.70 x V_{DD}	-	5.2	V
		Input voltage on true open-drain pins (PC0 and PC1) with $V_{DD} \geq 2$ V		-	5.5	
		Input voltage on five-volt tolerant (FT) pins (PA7 and PE0) with V_{DD} < 2 V	0.70 x V_{DD}	-	5.2	
		Input voltage on five-volt tolerant (FT) pins (PA7 and PE0) with $V_{DD} \geq 2$ V		-	5.5	
		Input voltage on 3.6 V tolerant (TT) pins		-	3.6	
		Input voltage on any other pin	0.70 x V_{DD}	-	V_{DD}+0.3	
V_{hys}	Schmitt trigger voltage hysteresis (3)	I/Os	-	200	-	mV
		True open drain I/Os	-	200	-	
I_{lkg}	Input leakage current (4)	$V_{SS} \leq V_{IN} \leq V_{DD}$ High sink I/Os	-	-	50 (5)	nA
		$V_{SS} \leq V_{IN} \leq V_{DD}$ True open drain I/Os	-	-	200(5)	
		$V_{SS} \leq V_{IN} \leq V_{DD}$ PA0 with high sink LED driver capability	-	-	200(5)	
R_{PU}	Weak pull-up equivalent resistor(2)(6)	$V_{IN}=V_{SS}$	30	45	60	kΩ
C_{IO}	I/O pin capacitance	-	-	5	-	pF

1. V_{DD} = 3.0 V, T_A = -40 to 125 °C unless otherwise specified.
2. Data based on characterization results.
3. Hysteresis voltage between Schmitt trigger switching levels. Based on characterization results, not tested.
4. The max. value may be exceeded if negative current is injected on adjacent pins.
5. Not tested in production.

NRST pin

Subject to general operating conditions for V_{DD} and T_A unless otherwise specified.

Table 42. $\overline{\text{NRST}}$ pin characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{IL(NRST)}$	NRST input low level voltage (1)	-	V_{SS}	-	0.8	V
$V_{IH(NRST)}$	NRST input high level voltage (1)	-	1.4	-	V_{DD}	
$V_{OL(NRST)}$	NRST output low level voltage (1)	I_{OL} = 2 mA for 2.7 V ≤V_{DD} ≤3.6 V	-	-	0.4	
		I_{OL} = 1.5 mA for V_{DD} < 2.7 V	-	-		
V_{HYST}	NRST input hysteresis(3)	-	10%V_{DD} (2)	-	-	mV
$R_{PU(NRST)}$	NRST pull-up equivalent resistor (1)	-	30	45	60	kΩ
$V_{F(NRST)}$	NRST input filtered pulse (3)	-	-	-	50	ns
$V_{NF(NRST)}$	NRST input not filtered pulse (3)	-	300	-	-	

1. Data based on characterization results.
2. 200 mV min.
3. Data guaranteed by design.

Figure 31. Typical NRST pull-up resistance R_{PU} vs V_{DD}

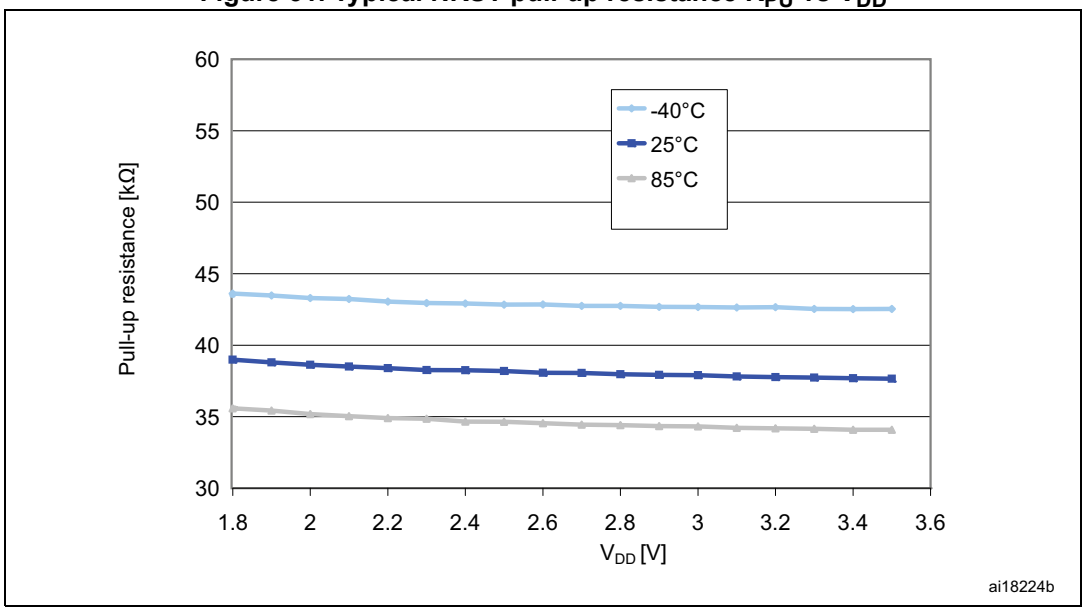
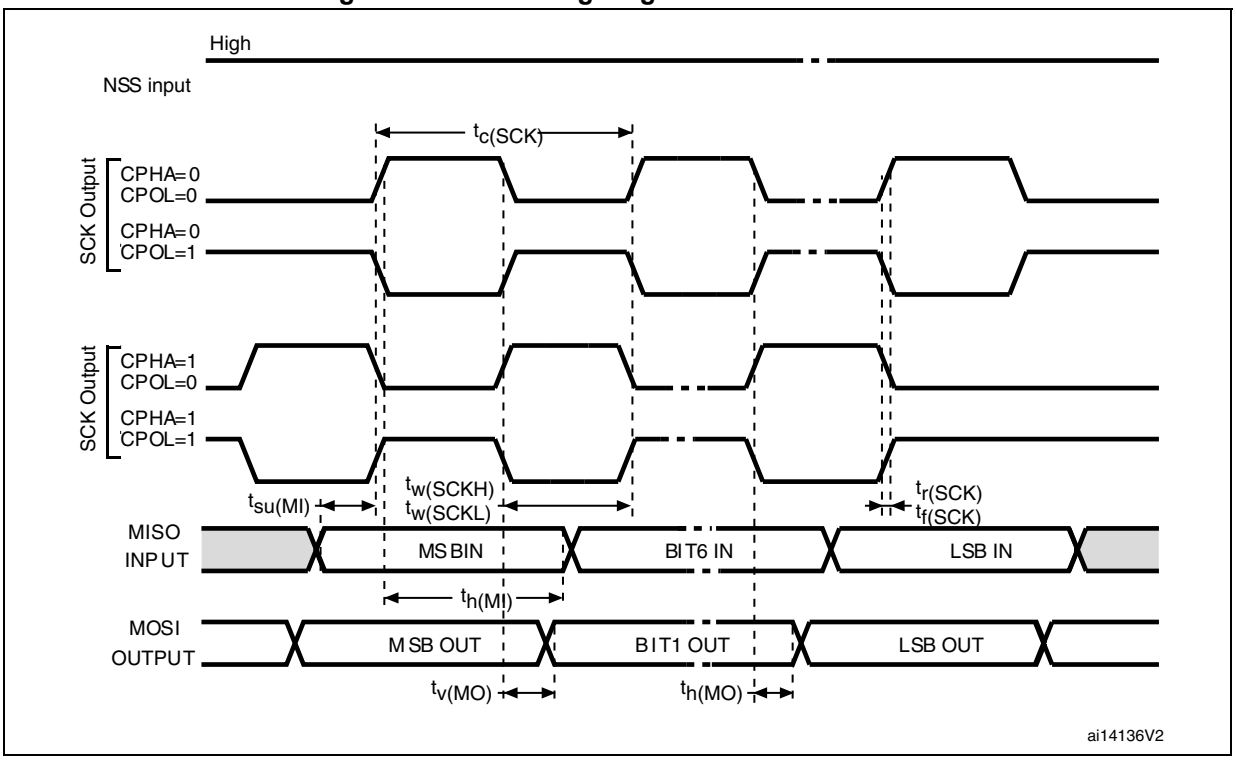


Figure 36. SPI1 timing diagram - master mode(1)



1. Measurement points are done at CMOS levels: $0.3V_{DD}$ and $0.7V_{DD}$.

Figure 38. ADC1 accuracy characteristics

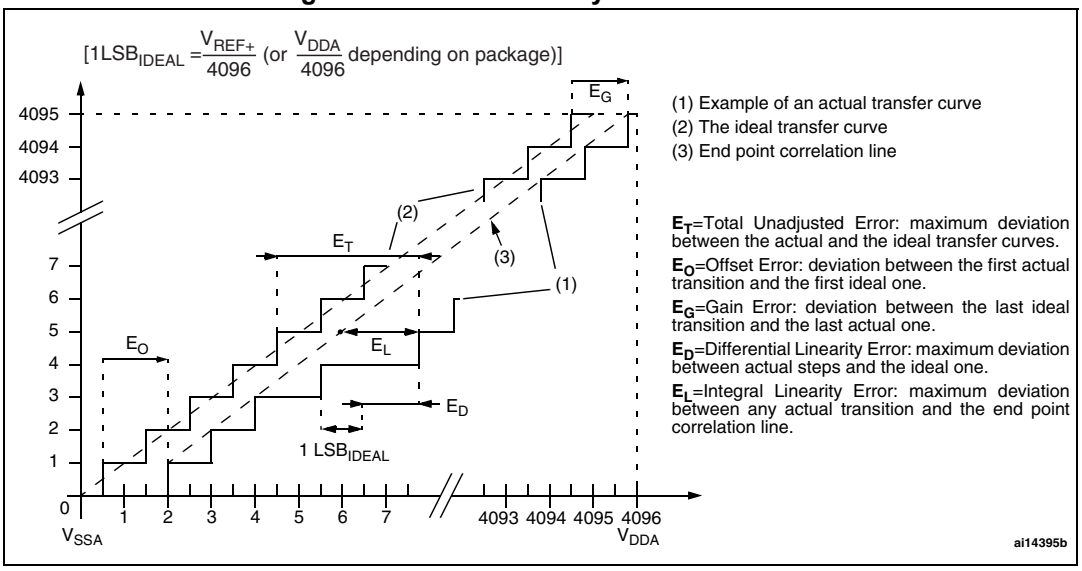
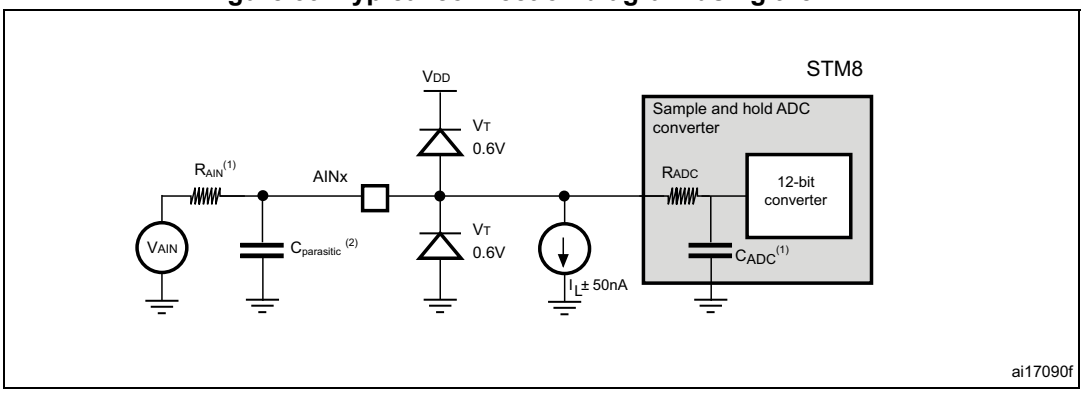


Figure 39. Typical connection diagram using the ADC



1. Refer to *Table 53* for the values of R_{AIN} and C_{ADC}.
2. $C_{parasitic}$ represents the capacitance of the PCB (dependent on soldering and PCB layout quality) plus the pad capacitance (roughly 7 pF). A high $C_{parasitic}$ value will downgrade conversion accuracy. To remedy this, f_{ADC} should be reduced.

Table 62. LQFP48 - 48-pin, 7 x 7 mm low-profile quad flat package mechanical data

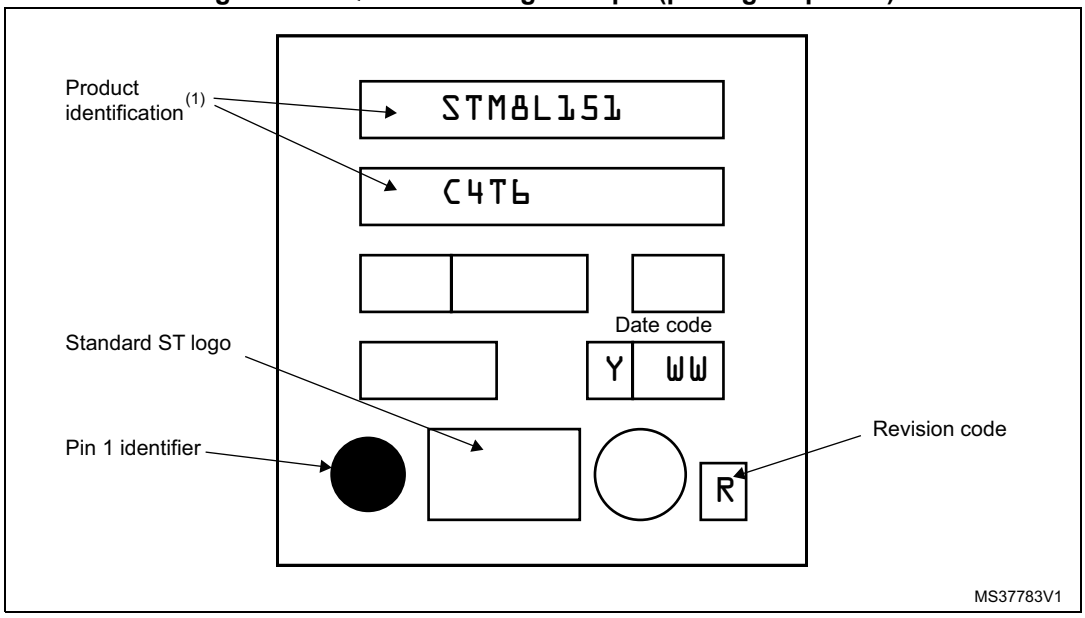
Symbol	millimeters			inches[1]		
	Min	Typ	Max	Min	Typ	Max
A	-	-	1.600	-	-	0.0630
A1	0.050	-	0.150	0.0020	-	0.0059
A2	1.350	1.400	1.450	0.0531	0.0551	0.0571
b	0.170	0.220	0.270	0.0067	0.0087	0.0106
c	0.090	-	0.200	0.0035	-	0.0079
D	8.800	9.000	9.200	0.3465	0.3543	0.3622
D1	6.800	7.000	7.200	0.2677	0.2756	0.2835
D3	-	5.500	-	-	0.2165	-
E	8.800	9.000	9.200	0.3465	0.3543	0.3622
E1	6.800	7.000	7.200	0.2677	0.2756	0.2835
E3	-	5.500	-	-	0.2165	-
e	-	0.500	-	-	0.0197	-
L	0.450	0.600	0.750	0.0177	0.0236	0.0295
L1	-	1.000	-	-	0.0394	-
k	0°	3.5°	7°	0°	3.5°	7°
ccc	-	-	0.080	-	-	0.0031

1. Values in inches are converted from mm and rounded to 4 decimal digits.

Device marking

The following figure gives an example of topside marking orientation versus pin 1 identifier location. Other optional marking or inset/upset marks, which depend on supply chain operations, are not indicated below.

Figure 45. LQFP48 marking example (package top view)

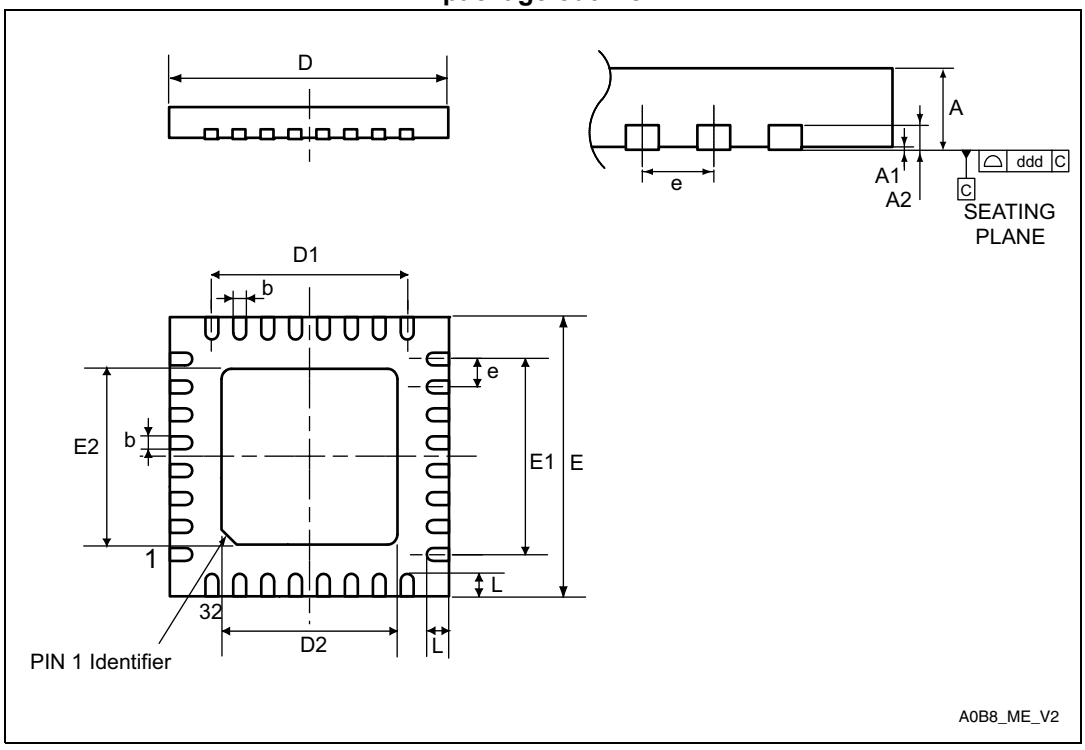


1. Parts marked as “ES”, “E” or accompanied by an Engineering Sample notification letter, are not yet qualified and therefore not yet ready to be used in production and any consequences deriving from such usage will not be at ST charge. In no event, ST will be liable for any customer usage of these engineering samples in production. ST Quality has to be contacted prior to any decision to use these Engineering Samples to run qualification activity.

Samples to run qualification activity.

10.5 UFQFPN32 package information

Figure 52. UFQFPN32 - 32-pin, 5 x 5 mm, 0.5 mm pitch ultra thin fine pitch quad flat package outline

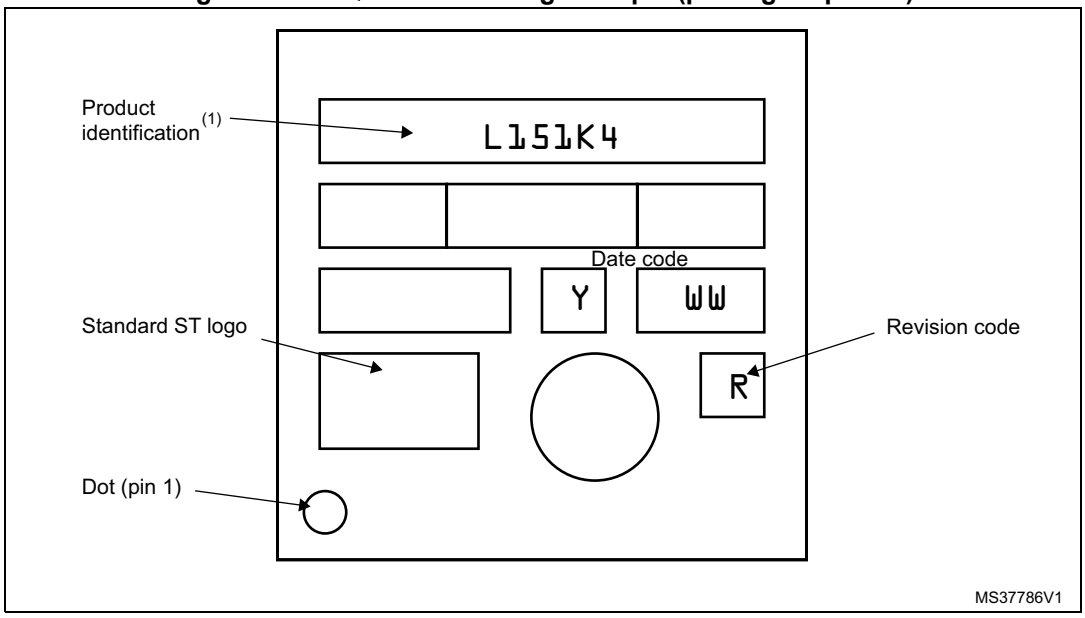


1. Drawing is not to scale.

Device marking

The following figure gives an example of topside marking orientation versus pin 1 identifier location. Other optional marking or inset/upset marks, which depend on supply chain operations, are not indicated below.

Figure 54. UFQFPN32 marking example (package top view)



1. Parts marked as “ES”, “E” or accompanied by an Engineering Sample notification letter, are not yet qualified and therefore not yet ready to be used in production and any consequences deriving from such usage will not be at ST charge. In no event, ST will be liable for any customer usage of these engineering samples in production. ST Quality has to be contacted prior to any decision to use these Engineering Samples to run qualification activity.

Table 67. WLCSP28 - 28-pin, 1.703 x 2.841 mm, 0.4 mm pitch wafer level chip scale package mechanical data

Symbol	millimeters			inches[1]		
	Min	Typ	Max	Min	Typ	Max
A	0.540	0.570	0.600	0.0213	0.0224	0.0236
A1	-	0.190	-	-	0.0075	-
A2	-	0.380	-	-	0.0150	-
b[2]	0.240	0.270	0.300	0.0094	0.0106	0.0118
D	1.668	1.703	1.738	0.0657	0.0670	0.0684
E	2.806	2.841	2.876	0.1105	0.1119	0.1132
e	-	0.400	-	-	0.0157	-
e1	-	1.200	-	-	0.0472	-
e2	-	2.400	-	-	0.0945	-
F	-	0.251	-	-	0.0099	-
G	-	0.222	-	-	0.0087	-
aaa	-	-	0.100	-	-	0.0039
bbb	-	-	0.100	-	-	0.0039
ccc	-	-	0.100	-	-	0.0039
ddd	-	-	0.050	-	-	0.0020
eee	-	-	0.050	-	-	0.0020

1. Values in inches are converted from mm and rounded to 4 decimal digits.
2. Dimension is measured at the maximum bump diameter parallel to primary datum Z.

Device marking

The following figure gives an example of topside marking orientation versus ball A1 identifier location. Other optional marking or inset/upset marks, which depend on supply chain operations, are not indicated below.

12 Revision history

Table 69. Document revision history

Date	Revision	Changes
06-Aug-2009	1	Initial release
10-Sep-2009	2	Updated peripheral naming throughout document. Added *Figure: STM8L151Cx 48-pin pinout (without LCD).* Added capacitive sensing channels in *Features.* Updated PA7, PC0 and PC1 in *Table: Medium density STM8L15x pin description.* Changed CLK and REMAP register names. Changed description of WDGHALT. Added typical power consumption values in *Table 18* to *Table 26.* Corrected VIH max value.
11-Dec-2009	3	Added WLCSP28 package Modified *Figure: Memory map* and added 2 notes. Modified Low power run mode in *Section: Low power modes.* Added *Section: Unique ID.* Modified *Table: Interrupt mapping* (added reserved area at address 0x00 8008) Modified OPT4 option bits in *Table: Option byte addresses.* *Table: Option byte description:* modified OPT0 description (“disable” instead of “enable”) and OPT1 description Added OPTBL option bytes Modified *Section: Electrical parameters.*
02-Apr-2010	4	Changed title of the document (STM8L151x4, STM8L151x6, STM8L152x4, STM8L152x6) Changed pinout (V_{SS1}, V_{DD1}, V_{SS2}, $V_{DD\ 2}$ instead of V_{SS}, $V_{DD,}$ V_{SSIO}, V_{DDIO} Changed packages Changed first page Modified note 1 in *Table: Medium density STM8L15x pin description.* Added note to PA7, PC0, PC1 and PE0 in *Table: Medium density STM8L15x pin description.* Modified *Figure: Memory map.* Modified *Table: WLCSP28 – 28-pin wafer level chip scale package, package mechanical data* (min and max columns swapped) Modified *Figure: WLCSP28 – 28-pin wafer level chip scale package, package outline* (A1 ball location) Renamed Rm, Lm and Cm EXTI_CONF replaced with EXTI_CONF1 in *Table: General hardware register map.* Updated *Section: Electrical parameters.*

Table 69. Document revision history (continued)

Date	Revision	Changes
10-Feb-2012	8	*Features:* replaced "'Dynamic consumption' with 'Consumption'. *Table: Medium density STM8L15x pin description*: updated OD column of NRST/PA1 pin. *Table: Interrupt mapping:* removed tamper 1, tamper 2 and tamper 3. *Figure: UFQFPN48 package outline:* replaced. *Table: UFQFPN48 package mechanical data:* updated title. *Figure: UFQFPN32 - 32-lead ultra thin fine pitch quad flat no-lead package outline (5 x 5):* removed the line over A1. *Figure: UFQFPN28 package outline:* replaced to improve readability of UFQFPN28 package dimensions A, L, and L1. *Figure: Recommended UFQFPN28 footprint (dimensions in mm)*: updated title. *Figure: WLCSP28 package outline:* updated title. *Table: WLCSP28 package mechanical data:* updated title.
02-Mar-2012	9	Updated *Table: UFQFPN48 package mechanical data.* Updated *Figure: UFQFPN28 package outline, Figure: Recommended UFQFPN28 footprint (dimensions in mm)* and *Table: UFQFPN28 package mechanical data.* *Table: WLCSP28 package mechanical data:* Min and Max values removed for e1, e2, e3, e4, F and G dimensions.
30-Mar-2012	10	*Figure: SPI1 timing diagram - master mode(1):* changed SCK signals to 'output' instead of 'input'. *Figure: Medium density STM8L15x ordering information scheme*: added 'Tape & reel' to package section.
26-Apr-2012	11	Updated *Table: WLCSP28 package mechanical data.*
12-Nov-2013	12	Updated *Table: WLCSP28 package mechanical data.* Updated *Table: Medium-density STM8L15x pin description.* Updated *Table 2: Medium density STM8L15x low power device features and peripheral counts*. Added *Figure: Recommended LQFP48 footprint* and *Figure: Recommended LQFP32 footprint.*
12-Aug-2013	13	Changed the default setting value of OPT5 to 0x00 in *Table: Option byte addresses*. Added tTEMP 'BOR detector enabled' and 'disabled' characteristics in *Table: Embedded reset and power control block characteristics*. Updated E2, D2 and ddd in *Table: UFQFPN48 package mechanical data*